

PATENT Customer No. 22,852 Attorney Docket No. 04329.3101-01

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:)
Koji USUDA, et al.) <i>Prior</i> Group Art Unit: 2814
Div. of Application No.: 10/627,648, filed July 28, 2003) <i>Prior</i> Examiner: Cao, Phat X.
Filed: August 9, 2004))
For: SEMICONDUCTOR APPARATUS))
Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450	
Sir:	

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT UNDER 37 C.F.R. § 1.97(b)

Pursuant to 37 C.F.R. §§ 1.56 and 1.97(b), Applicants bring to the attention of the Examiner the documents listed on the attached PTO-1449. Applicants are filing this Supplemental Information Disclosure Statement (IDS) before the mailing date of a first Office Action on the merits for the above-referenced application, to the undersigned representative's knowledge at the time this paper was filed. This IDS supplements the IDS filed on August 9, 2004.

Applicants attach copies of the listed documents. Applicants respectfully request that the Examiner consider the listed documents and indicate their consideration by making appropriate notation on the attached PTO-1449 Form.

In lieu of a statement of relevance or full translation of the non-English documents,

Applicants enclose the attached Japanese Patent Office Action entitled "Notification of Reasons

for Rejection," mailed July 20, 2004 in a counterpart foreign application, citing and setting forth

the relevance of the attached documents. An English language translation of the Japanese Patent

Office Action is also enclosed.

Applicants also attach a corrected copy of the PTO-1449 form filed with the IDS of

August 9, 2004. This PTO-1449 corrects the prior application number listed on the form.

Applicants respectfully request the Examiner initial and return a copy of this corrected PTO-

1449 form.

This submission does not represent that a search has been made or that no better art

exists, and does not constitute an admission that the listed documents are material or constitute

"prior art." If the Examiner applies the documents as prior art against any claim in the

application and Applicants determine that the cited documents do not constitute "prior art" under

United States law, Applicants reserve the right to present to the Office the relevant facts and law

regarding the appropriate status of such documents.

Applicants further reserve the right to take appropriate action to establish the patentability

of the disclosed invention over the listed documents, should the documents be applied against the

claims of the present application.

If there is any fee due in connection with the filing of this Statement, please charge the

fee to our Deposit Account No. 06-0916.

Respectfully submitted,

FINNEGAN, HENDERSON, FARABOW,

GARRETT & DUNNER, L.L.P.

Reg. No. 53,235

Dated: August 18, 2004

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INFORMATION DISCLOSURE CITATION

Atty. Docker Vo	04329.3101-01	Div. of Appln. No.	1 0/627,648
Applicant	Koji USUDA, et al.		
Filing Date	August 9, 2004	Prior Group:	2814

U.S. PATENT DOCUMENTS						
Examiner Initial*	Document Number	Issue Date	Name	Class	Sub Class	Filing Date If Appropriate
			<u> </u>			

FOREIGN PATENT DOCUMENTS						
	Document Number	Publication Date	Country	Class	Sub Class	Translation Yes or No
	2003-234472	08/2003	Japan			No

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)					

Examiner	-	Date Considered
*Examiner:		onsidered, whether or not citation is in conformance with MPEP 609; draw line ot in conformance and not considered. Include copy of this form with next applicant.
Form PTO 14	49	Patent and Trademark Office - U.S. Department of Commerce



INFORMATION DISCLOSURE CITATION

Atty. Docket No.	04329.3101-01:	AVR . G	Div. of Appln. No.	1 0/627,648	
Applicant	Koji USUDA, et a	2004			
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U.S. PATENT DOCUMENTS						
Examiner Initial*	Document Number	Issue Date	Name	Class	Sub Class	Filing Date If Appropriate

FOREIGN PATENT DOCUMENTS						
	Document Number	Publication Date	Country	Class	Sub Class	Translation Yes or No

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)
McKee et al. "PHYSICAL STRUCTURE AND INVERSION CHARGE AT A SEMICONDUCTOR INTERFACE WITH A CRYSTALLINE OXIDE", Science, Vol. 293, pages 468-471, (2001)
Nishikawa et al., "DIRECT GROWTH OF SINGLE CRYSTALLINE CeO ₂ HIGH-K GATE DIELECTRICS", Extended Abstracts of the 2001 International Conference on Solid State Devices and Materials, pages 174-175, (2001)
Gottschalk et al., "EPITAXIAL Pr_2O_3 ON SILICON AS AN ALTERNATIVE GATE OXIDE FOR FUTURE CMOS APPLICATIONS", JOINT SESSION CRYSTALLINE OXIDES FOR GATE DIELECTRICS, Session N8.5/T6.5, pages 350-351, (2002)
Tezuka et al., "NOVEL FULLY-DEPLETED SiGe-ON-INSULATOR pMOSFETs WITH HIGH-MOBILITY SiGe SURFACE CHANNELS", IEDM Tech. Dig., 946, IEEE, (2001)
Welser et al.; "STRAIN DEPENDENCE OF THE PERFORMANCE ENHANCEMENT IN STRAINED-Si n-MOSFETs"; IEDM, pages, 373-376, IEEE, (1994)
Hirose et al.; "FUNDAMENTAL LIMIT OF GATE OXIDE THICKNESS SCALING IN ADVANCED MOSFETs"; Semicond. Sci. Technol. Vol. 15, pages 485-490, (2000)

Examiner		Date Considered
*Examiner:		ot citation is in conformance with MPEP 609; draw line not considered. Include copy of this form with next
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The PTO did not receive the following listed Item(s) NPL documents.